V <sub>RRM</sub>	=	4500 V
I <sub>FAVM</sub>	=	650 A
I <sub>FSM</sub>	=	16 kA
V <sub>F0</sub>	=	1.4 V
r <sub>F</sub>	=	<b>1 m</b> Ω
V <sub>DClink</sub>	=	2800 V

# Fast Recovery Diode 5SDF 07F4501

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- Patented free-floating silicon technology
- Low on-state and switching losses
- Optimized for use as freewheeling diode in GTO converters with high DC link voltages
- Standard press-pack housing, hermetically cold-welded
- Cosmic radiation withstand rating

# Blocking

V <sub>RRM</sub>	Repetitive peak reverse voltage	4500 V	Half sine wav	e, t <sub>P</sub> = 10 ms, f = 50 Hz
I <sub>RRM</sub>	Repetitive peak reverse current	$\leq$ 50 mA	$V_{R} = V_{RRM,} T_{j}$	= 125°C
V <sub>DClink</sub>	Permanent DC voltage for 100 FIT failure rate	2800 V	100% Duty	Ambient cosmic radiation at sea level in open air.

### Mechanical data (see Fig. 11)

E	Mounting force	min.		20 kN
F <sub>m</sub>		max.		24 kN
а	Acceleration:			
	Device unclamped			50 m/s <sup>2</sup>
	Device clamped			200 m/s <sup>2</sup>
m	Weight			0.46 kg
Ds	Surface creepage distance		$\geq$	33 mm
Da	Air strike distance		≥	20 mm



### **On-state** (see Fig. 1, 2)

I <sub>FAVM</sub>	Max. average on-state current	650 A	Half sine wave, $T_c = 85^{\circ}C$
I <sub>FRMS</sub>	Max. RMS on-state current	1000 A	
I <sub>FSM</sub>	Max. peak non-repetitive	16 kA	tp = 10 ms Before surge:
	surge current	44 kA	$tp = 1 ms T_c = T_j = 125^{\circ}C$
∫l²dt	Max. surge current integral	1.28·10 <sup>6</sup> A <sup>2</sup> s	tp = 10 ms After surge:
		0.8·10 <sup>6</sup> A <sup>2</sup> s	tp = 1 ms $V_R \approx 0 V$
$V_{F}$	Forward voltage drop	$\leq$ 2.7 V	I <sub>F</sub> = 1250 A
$V_{\text{F0}}$	Threshold voltage	1.4 V	Approximation for $T_j = 125^{\circ}C$
r <sub>F</sub>	Slope resistance	1 mΩ	I <sub>F</sub> = 4002000 A

# Turn-on (see Fig. 3, 4)

$V_{fr}$ Peak forward recovery voltage $\leq$	74 V di/dt = 500 A/µs, T <sub>j</sub> = 125°0
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# Turn-off (see Fig. 5 to 10)

Irr	Reverse recovery current	$\leq$	600 A	$di/dt = 100 A/\mu s, I_F = 2000 A,$
Q <sub>rr</sub>	Reverse recovery charge	$\leq$	1900 µC	$T_j = 125^{\circ}C, V_{RM} = 2500 V,$
Err	Turn-off energy	$\leq$	1 J	$C_S = \mu F (GTO snubber circuit)$

### Thermal (see Fig. 12)

Tj	Operating junction temperature range	-4	0125°C		
T <sub>stg</sub>	Storage temperature range	-4	0125°C		
$R_{thJC}$	Thermal resistance junction to case	$\leq$	40 K/kW	Anode side cooled	
		$\leq$	40 K/kW	Cathode side cooled	F <sub>M</sub> =
		$\leq$	20 K/kW	Double side cooled	20… 24 kN
$R_{thCH}$	Thermal resistance case to heatsink	≤	10 K/kW	Single side cooled	
		$\leq$	5 K/kW	Double side cooled	

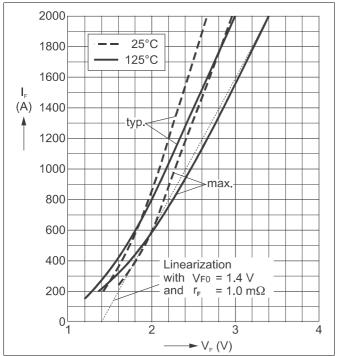


Fig. 1 Forward current vs. forward voltage (typ. and max. values) and linear approximation of max. curve at 125°C.

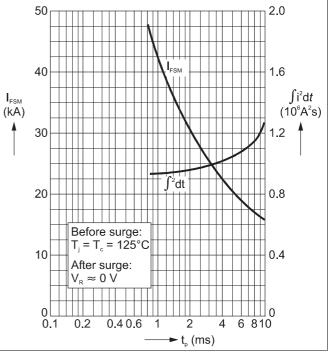


Fig. 2 Surge current and fusing integral vs. pulse width (max. values) for non-repetitive, half-sinusoidal surge current pulses.

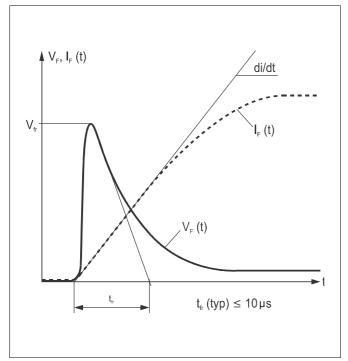


Fig. 3 Typical forward voltage waveform when the diode is turned on with a high di/dt.

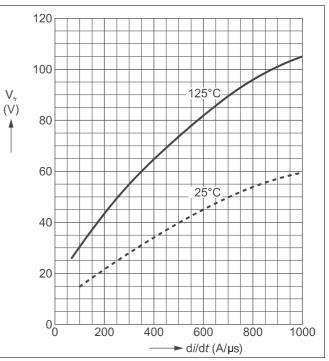


Fig. 4 Forward recovery voltage vs. turn-on di/dt (max. values).

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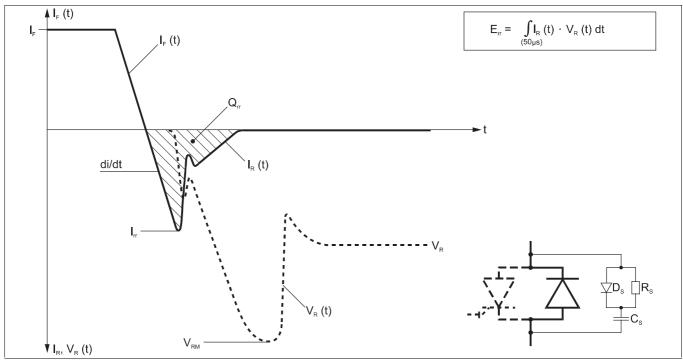


Fig. 5 Typical current and voltage waveforms at turn-off when the diode is connected to an RCD snubber, as often used in GTO circuits.

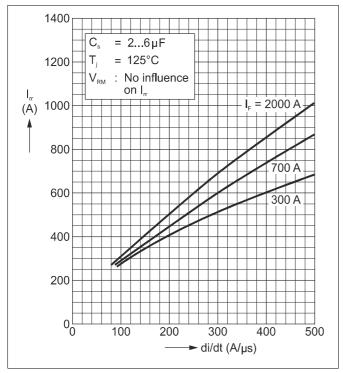


Fig. 6 Reverse recovery current vs. turn off di/dt (max. values).

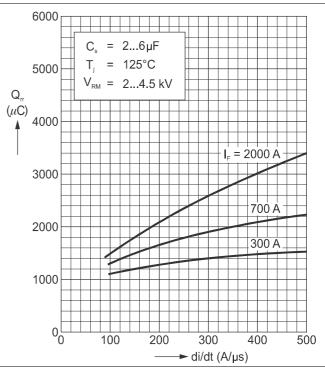


Fig. 7 Reverse recovery charge vs. turn off di/dt (max. values).

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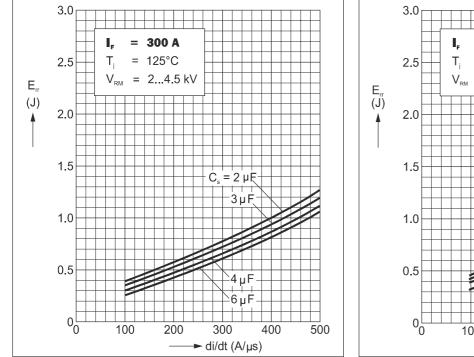


Fig. 8 Turn-off energy vs. turn-off di/dt for  $I_F = 300 \text{ A} \text{ (max. values)}.$ 

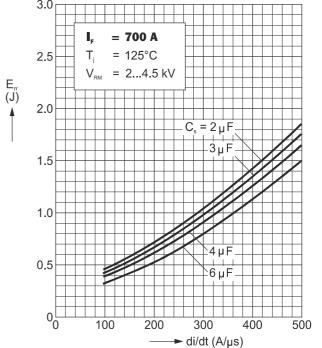
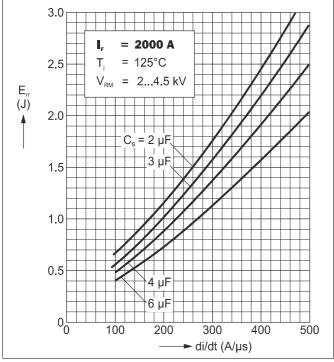
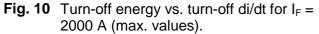
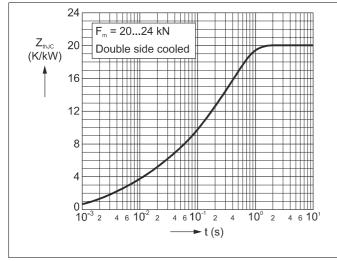


Fig. 9 Turn-off energy vs. turn-off di/dt for  $I_F = 700 \text{ A} \text{ (max. values)}.$ 

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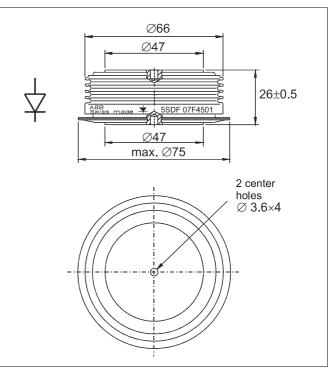


Fig. 11 Outline drawing. All dimensions are in millimeters and represent nominal values unless stated otherwise.

Z thJC (t) = 
$$\sum_{i=1}^{4} R_i (1 - e^{-t/\tau_i})$$

i	1	2	3	4
R <sub>I</sub> (K/kW)	11.83	4.26	1.63	2.28
τ <sub>i</sub> (s)	0.432	0.071	0.01	0.0054

 $F_m = 20...24$  kN Double side cooled

Fig. 12 Transient thermal impedance (junction-to-case) vs. time in analytical and graphical form (max. values).

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